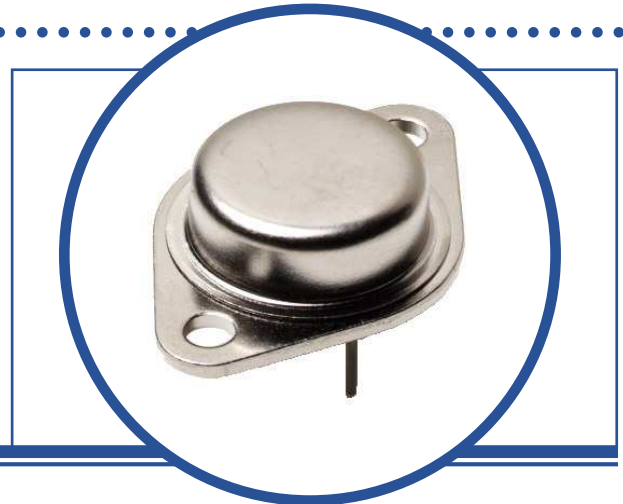


N-CHANNEL POWER MOSFET

IRF330 / 2N6760

- Power MOSFET Transistor
In A Hermetic Metal TO-3 Package
- High Input Impedance / $R_{DS(on)} < 1.0\Omega$
- Designed For Switching, Power Supply,
Motor Control and Amplifier Applications
- Screening Options Available



ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ unless otherwise stated)

VDS	Drain – Source Voltage		400V
VGS	Gate – Source Voltage		$\pm 20\text{V}$
I_D	Continuous Drain Current	$T_C = 25^\circ\text{C}$	5.5A
I_D	Continuous Drain Current	$T_C = 100^\circ\text{C}$	3.5A
I_{DM}	Pulsed Drain Current ⁽¹⁾		22A
P_D	Total Power Dissipation at	$T_C = 25^\circ\text{C}$	75W
		Derate Above 25°C	$0.6\text{W}/^\circ\text{C}$
E_{AS}	Single Pulse Avalanche Energy ⁽²⁾		1.7mJ
I_{AR}	Avalanche Current ⁽¹⁾		5.5A
dv/dt	Peak Diode Recovery ⁽³⁾		4V/ns
T_J	Junction Temperature Range		-55 to $+150^\circ\text{C}$
T_{stg}	Storage Temperature Range		-55 to $+150^\circ\text{C}$
T_L	Lead Temperature (1.6mm (0.063”) from case for 10sec)		300°C

THERMAL PROPERTIES

Symbols	Parameters	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction To Case	1.67	$^\circ\text{C}/\text{W}$

INTERNAL PACKAGE INDUCTANCE

Symbols	Parameters	Typ.	Units
$L_S + L_D$	Total Inductance	6.1	nH

Notes

- (1) Repetitive Rating: Pulse width limited by maximum junction temperature
- (2) @ $V_{DD} = 50\text{V}$, Peak $I_L = 5.5\text{A}$, Starting $T_J = 25^\circ\text{C}$
- (3) @ $I_{SD} \leq 5.5\text{A}$, $di/dt \leq 90\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, $T_J \leq 150^\circ\text{C}$, Suggested $R_G = 7.5\Omega$
- (4) Pulse Width $\leq 300\mu\text{s}$, $\delta \leq 2\%$

Semelab Limited reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

N-CHANNEL POWER MOSFET IRF330 / 2N6760

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise stated)

Symbols	Parameters	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 I _D = 1.0mA	400			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Temperature Coefficient of Breakdown Voltage	Reference to 25°C I _D = 1.0mA		0.46		V/°C
R _{DS(on)}	Static Drain-Source On-State Resistance	V _{GS} = 10V I _D = 3.5A ⁽⁴⁾			1.0	Ω
		V _{GS} = 10V I _D = 5.5A ⁽⁴⁾			1.22	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} I _D = 250μA	2		4	V
g _{fs}	Forward Transconductance	V _{DS} ≥ 15V I _{DS} = 3.5A ⁽⁴⁾	2.9			S(Ω)
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0 V _{DS} = 0.8BV _{DSS} T _J = 125°C			25	μA
					250	
I _{GSS}	Forward Gate-Source Leakage	V _{GS} = 20V			100	nA
I _{GSS}	Reverse Gate-Source Leakage	V _{GS} = -20V			-100	

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	V _{GS} = 0		620		pF
C _{oss}	Output Capacitance	V _{DS} = 25V		200		
C _{rss}	Reverse Transfer Capacitance	f = 1.0MHz		75		
Q _g	Total Gate Charge	V _{GS} = 10V	17		39	nC
Q _{gs}	Gate-Source Charge	I _D = 5.5A	2		6	
Q _{gd}	Gate-Drain Charge	V _{DS} = 0.5BV _{DSS}	8		20	
t _{d(on)}	Turn-On Delay Time	V _{DD} = 200V			30	ns
t _r	Rise Time	I _D = 5.5A			40	
t _{d(off)}	Turn-Off Delay Time				80	
t _f	Fall Time	R _G = 7.5Ω			35	

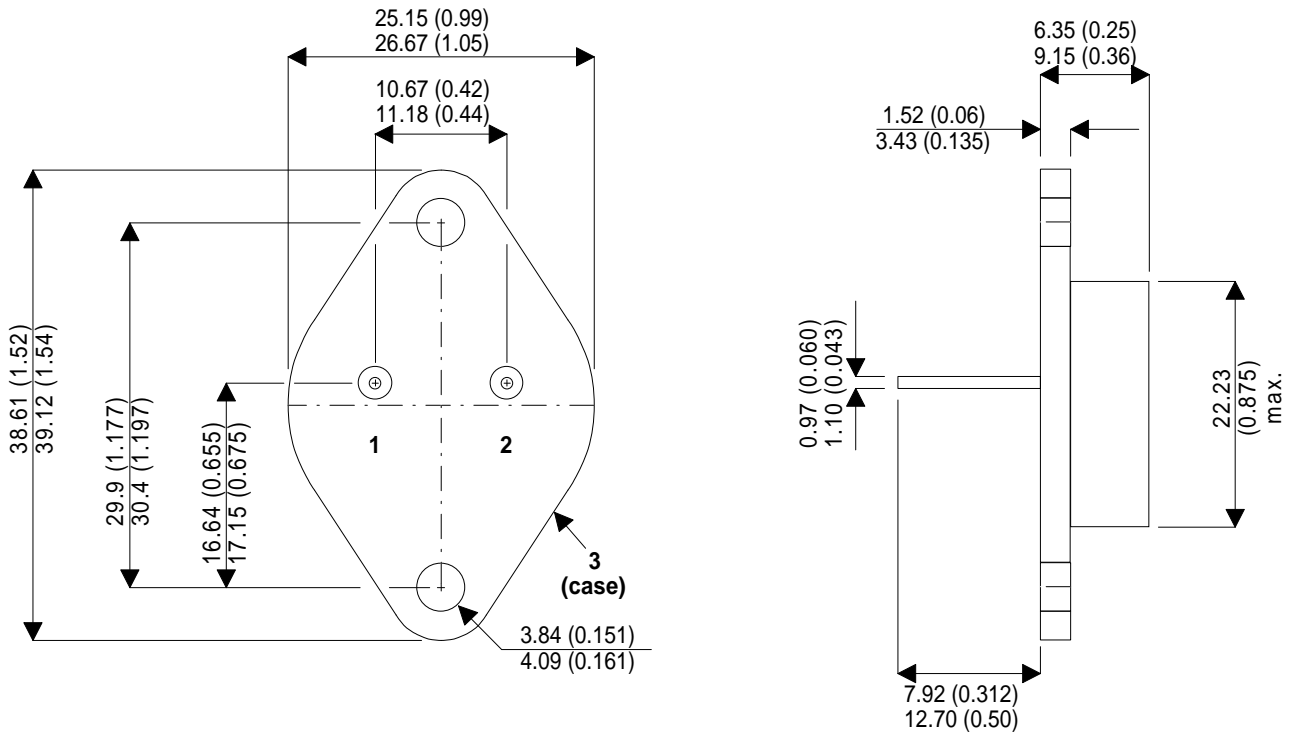
SOURCE-DRAIN DIODE CHARACTERISTICS

I _S	Continuous Source Current				5.5	A
I _{SM}	Pulse Source Current ⁽¹⁾				22	
V _{SD}	Diode Forward Voltage	I _S = 5.5A V _{GS} = 0 ⁽⁴⁾	T _J = 25°C		1.4	V
t _{rr}	Reverse Recovery Time	I _F = 5.5A	T _J = 25°C		700	ns
Q _{rr}	Reverse Recovery Charge	V _{DD} ≤ 50V	di/dt = 100A/μs ⁽⁴⁾		6.2	μC

N-CHANNEL POWER MOSFET IRF330 / 2N6760

MECHANICAL DATA

Dimensions in mm (inches)



TO3 (TO-204AA)

Pin 1 - Gate

Pin 2 - Source

Case - Drain